

Search Notes

Application/Control No.

09/854,666

Examiner

Ellen C. Tran

Applicant(s)/Patent under
Reexamination

UCHIDA, KAORU

Art Unit

2134

SEARCHED


Class	Subclass	Date	Examiner
713	170	10/13/2005	ECT
713	186	10/13/2005	ECT
713	170	8/21/2006	ECT
713	186	8/21/2006	ECT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	10/13/2005	ECT
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	8/21/2006	ECT

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	09/854,666		UCHIDA, KAORU	
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	Ellen C. Tran		2134	

SEARCHED			
Class	Subclass	Date	Examiner
UPDATED	SEARCH	4/15/2005	ECT

INTERFERENCE SEARCHED			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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Class	Subclass	Date	Examiner
713	170	9/17/2004	ECT
713	186	9/17/2004	ECT
382	115	9/17/2004	ECT

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
DBL PATENT	9/17/2004	ECT
INVENTOR	9/17/2004	ECT
USPTO	9/17/2004	ECT
USPG	9/17/2004	ECT
EPO	9/17/2004	ECT
JPO	9/17/2004	ECT
DERWENT	9/17/2004	ECT
IBM TECH DES	9/17/2004	ECT